## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination FUNG ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,708,814 A	01-1998	Short et al.	710/260
	В	US-6,175,890 B1	01-2001	Yamaura, Shinichi	710/267
	С	US-			
	D	US-			
	Е	US-		·	
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

10(2.0) 17(2.0)							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р				·		
	Q						
	R						
	S						
	Т						

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.